

IGBT - Power, Co-PAK, N-Channel, Field Stop VII, (FS7), SCR, Power TO247-3L 1200 V, 1.38 V, 25 A AFGHL25T120RWD

Description

Using the novel field stop 7th generation IGBT technology and the Gen7 Diode in TO247 3-lead package, this device offers the optimum performance with low on state voltage and minimal switching losses for both hard and soft switching topologies in automotive applications.

Features

- Extremely Efficient Trench with Field Stop Technology
- Maximum Junction Temperature $T_J = 175$ °C
- Short Circuit Rated and Low Saturation Voltage
- Fast Switching and Tightened Parameter Distribution
- AEC-Q101 Qualified, PPAP Available Upon Request
- This Device is Pb–Free, Halogen Free/BFR Free and is RoHS Compliant

Applications

- Automotive E-compressor
- Automotive EV PTC Heater
- OBC

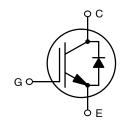
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Paramete	Symbol	Value	Unit	
Collector-to-Emitter Voltage		V_{CE}	1200	V
Gate-to-Emitter Voltage		V_{GE}	±20	
Transient Gate-to-Emitter V	oltage/		±30	
Collector Current	T _C = 25°C	I _C	50	Α
	T _C = 100°C		25	
Power Dissipation	T _C = 25°C	P_{D}	405	W
	T _C = 100°C		202	
Pulsed Collector Current	$T_C = 25^{\circ}C,$ $t_p = 10 \mu s \text{ (Note 1)}$	I _{CM}	75	Α
Diode Forward Current	T _C = 25°C)	ΙF	50	
	T _C = 100°C		25	
Pulsed Diode Maximum $T_C = 25^{\circ}C$, Forward Current $t_p = 10 \mu s$ (Note 1)		I _{FM}	75	
Short Circuit Withstand Time $V_{GE} = 15 \text{ V}, V_{CC} = 800 \text{ V}, T_{CC}$	T _{SC}	6	μs	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C
Lead Temperature for Solde	TL	260		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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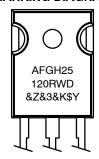
BV _{CES}	V _{CE(sat)} TYP	I _C MAX
1200 V	1.38 V	25 A



COPACK IGBT



MARKING DIAGRAM



AFGH25120RWD = Specific Device Code &Z = Assembly Plant Code &3 = 3-Digit Date Code

&K = 2-Digit Lot Traceability Code \$Y = **onsemi** Logo

ORDERING INFORMATION

Device	Package	Shipping
AFGHL25T120RWD	TO247-3L (Pb-Free)	30 Units / Tube

^{1.} Repetitive rating: Pulse width limited by max. junction temperature

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-to-Case, for IGBT	$R_{\theta JC}$	0.37	°C/W
Thermal Resistance Junction-to-Case, for Diode		0.68	
Thermal Resistance Junction-to-Ambient	$R_{\theta JA}$	40	

ELECTRICAL CHARACTERISTICS OF IGBT

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS (T _J = 25°C	unless otherwise	e specified)		-	-	-
Collector-to-Emitter Breakdown Voltage	BV _{CES}	V_{GE} = 0 V, I_C = 5 mA	1200	_	-	V
Collector-to-Emitter Breakdown Voltage Temperature Coefficient	$\Delta BV_{CES}/\Delta T_{J}$		-	1226	-	mV/°C
Zero Gate Voltage Collector Current	I _{CES}	V _{GE} = 0 V, V _{CE} = V _{CES}	-	-	40	μΑ
Gate-to-Emitter leakage Current	I _{GES}	V _{GE} = ±20 V, V _{CE} = 0 V	_	-	±400	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GE(th)}	$V_{GE} = V_{CE}, I_C = 25 \text{ mA}, T_J = 25^{\circ}\text{C}$	5.03	5.93	6.83	V
Gate-to-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} = 15 V, I _C = 25 A, T _J = 25°C	_	1.38	1.71	V
		V _{GE} = 15 V, I _C = 25 A, T _J = 175°C	_	1.64	_	
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{IES}	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	-	3054	-	pF
Output Capacitance	C _{OES}		-	126	-	1
Reverse Transfer Capacitance	C _{RES}		-	15.4	_	
Total Gate Charge	Q_{G}	V _{CE} = 600 V, I _C = 25 A, V _{GE} = 15 V	-	113	_	nC
Gate-to-Emitter Charge	Q_{GE}		-	27.2	_	-
Gate-to-Collector Charge	Q_{GC}		-	49.5	_	
SWITCHING CHARACTERISTIC, IND	UCTIVE LOAD					-
Turn-On Delay Time	t _{d(on)}	$V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V},$		33.8	_	ns
Turn-Off Delay Time	t _{d(off)}	$I_C = 12.5 \text{ A}, R_G = 4.7 \Omega, T_J = 25^{\circ}C$	-	223	_	
Rise Time	t _r		-	19.7	_	
Fall Time	t _f		-	192	_	
Turn-On Switching Loss	E _{on}		-	0.55	_	mJ
Turn-Off Switching Loss	E _{off}		-	0.86	_	
Total Switching Loss	E _{ts}		-	1.41	_	
Turn-On Delay Time	t _{d(on)}	$V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V},$	-	36.9	_	ns
Turn-Off Delay Time	t _{d(off)}	$I_C = 25 \text{ A}, R_G = 4.7 \Omega, T_J = 25^{\circ}\text{C}$	-	175	_	
Rise time	t _r		-	35.4	_	
Fall Time	t _f		-	126	-	
Turn-On Switching Loss	E _{on}		_	1.57	_	mJ
Turn-Off Switching Loss	E _{off}		_	1.06	_	1
Total Switching Loss	E _{ts}		-	2.62	-	

ELECTRICAL CHARACTERISTICS OF IGBT (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC, INI	DUCTIVE LOAD					
Turn-On Delay Time	t _{d(on)}	V _{CE} = 600 V, V _{GE} = 0/15 V,	-	37.7	_	ns
Turn-Off Delay Time	t _{d(off)}	$I_C = 12.5 \text{ A}, R_G = 4.7 \Omega, T_J = 175^{\circ}\text{C}$	-	315	-	
Rise Time	t _r	1 [-	27.1	-	
Fall Time	t _f	1 [-	384	-	
Turn-On Switching Loss	E _{on}	1 [-	0.78	-	mJ
Turn-Off Switching Loss	E _{off}	1 [-	1.6	-	
Total Switching Loss	E _{ts}	1 [-	2.38	-	
Turn-On Delay Time	t _{d(on)}	$V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V},$	-	42.2	-	ns
Turn-Off Delay Time	t _{d(off)}	$I_C = 25 \text{ A}, R_G = 4.7 \Omega, T_J = 175^{\circ}\text{C}$	-	235	-	
Rise Time	t _r	1 [-	46.5	-	
Fall Time	t _f	1 [-	242	-	
Turn-On Switching Loss	E _{on}	1	-	2.23	-	mJ
Turn-Off Switching Loss	E _{off}		-	1.9	-	
Total Switching Loss	E _{ts}	1	-	4.14	-	1 !
DIODE CHARACTERISTICS						
Diode Forward Voltage	V _F	I _F = 25 A, T _J = 25°C	-	1.71	2.01	V
		I _F = 25 A, T _J = 175°C	-	1.67	-	
DIODE SWITCHING CHARACTERIS	TIC, INDUCTIVI	E LOAD				
Reverse Recovery Time	t _{rr}	$V_R = 600 \text{ V, } I_F = 12.5 \text{ A,}$ $dI_F/dt = 500 \text{ A/}\mu\text{s, } T_J = 25^{\circ}\text{C}$	-	133	_	ns
Reverse Recovery Charge	Q _{rr}		-	1179	-	nC
Reverse Recovery Energy	E _{rec}		-	0.39	-	mJ
Peak Reverse Recovery Current	I _{RRM}		-	22.1	-	Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 25 A,	-	173	-	ns
Reverse Recovery Charge	Q _{rr}	$dI_F/dt = 500 \text{ A}/\mu\text{s}, T_J = 25^{\circ}\text{C}$	-	2136	-	nC
Reverse Recovery Energy	E _{rec}	1 [-	0.65	-	mJ
Peak Reverse Recovery Current	I _{RRM}	1 [-	28.4	-	Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 12.5 A,	-	180	-	ns
Reverse Recovery Charge	Q _{rr}	- dI _F /dt = 500 A/μs, T _J = 175°C -	_	1775	-	nC
Reverse Recovery Energy	E _{rec}		-	0.67	-	mJ
Peak Reverse Recovery Current	I _{RRM}		_	24.5	_	Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 25 A,	_	229	_	ns
Reverse Recovery Charge	Q _{rr}	$-dI_F/dt = 500 \text{ A/}\mu\text{s}, T_J = 175^{\circ}\text{C}$	_	3383	_	nC
Reverse Recovery Energy	E _{rec}		_	1.16	_	mJ
Peak Reverse Recovery Current	I _{RRM}	†	_	34	_	Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

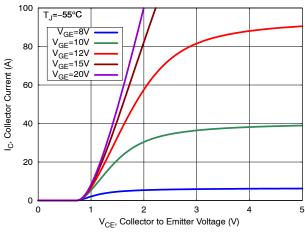


Figure 1. Output Characteristics

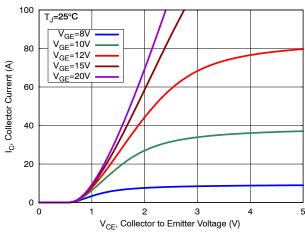


Figure 2. Output Characteristics

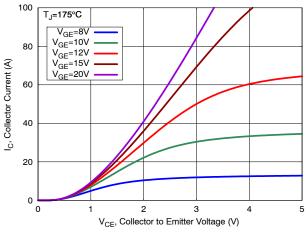


Figure 3. Output Characteristics

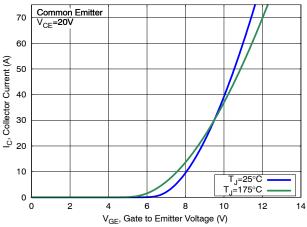


Figure 4. Transfer Characteristics

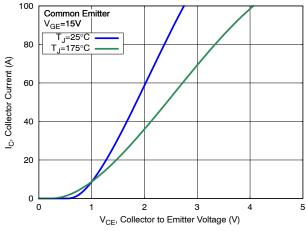


Figure 5. Saturation Characteristics

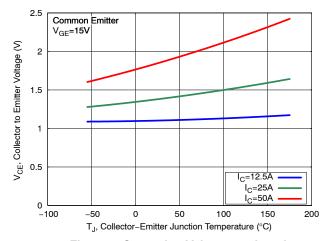


Figure 6. Saturation Voltage vs. Junction Temperature

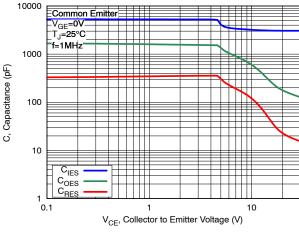


Figure 7. Capacitance Characteristics

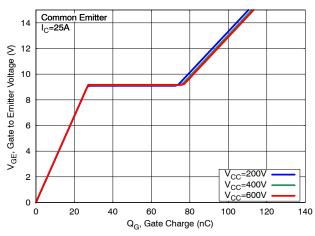


Figure 8. Gate Charge Characteristics

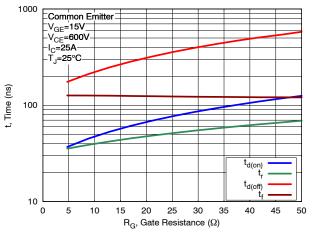


Figure 9. Switching Time vs Gate Resistance

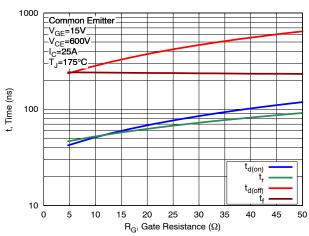


Figure 10. Switching Time vs Gate Resistance

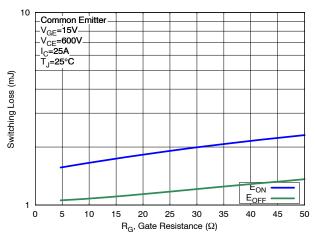


Figure 11. Switching Loss vs Gate Resistance

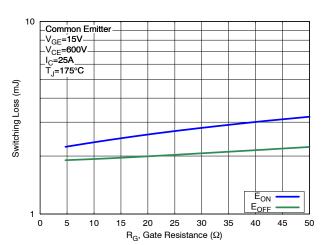


Figure 12. Switching Loss vs Gate Resistance

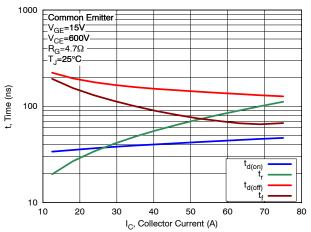


Figure 13. Switching Time vs Collector Current

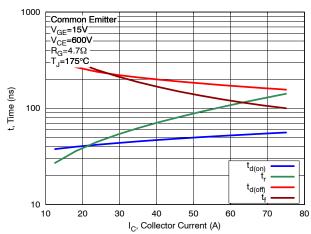


Figure 14. Switching Time vs Collector Current

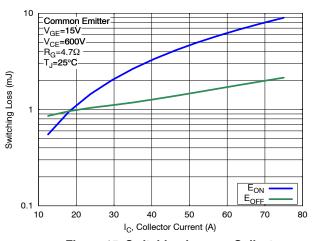


Figure 15. Switching Loss vs Collector Current

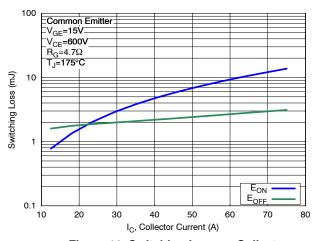


Figure 16. Switching Loss vs Collector Current

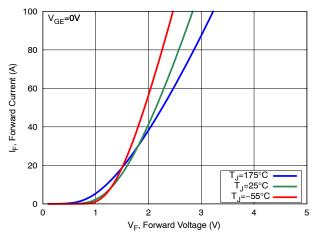


Figure 17. Diode Forward Characteristics

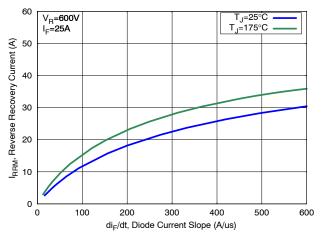
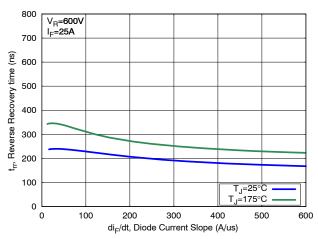


Figure 18. Diode Reverse Recovery Current



8000 V_R=600V I_F=25A 7000 Reverse Recovery Charge (nC) 6000 5000 4000 3000 2000 ď 1000 T_J=25°C T_J=175°C 0 0 100 300 400 600 di_F/dt, Diode Current Slope (A/us)

Figure 19. Diode Reverse Recovery Current

Figure 20. Diode Stored Charge Characteristics

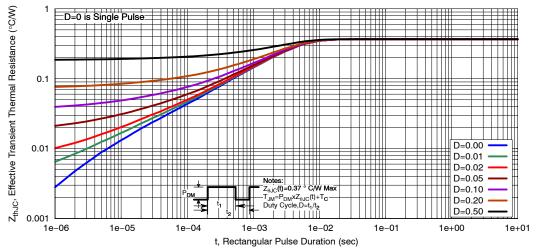


Figure 21. Transient Thermal Impedance of IGBT

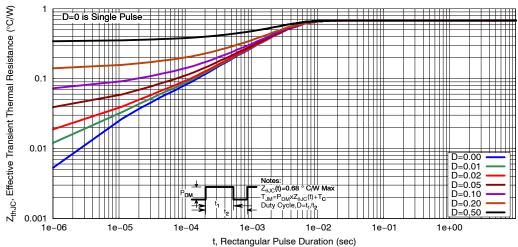
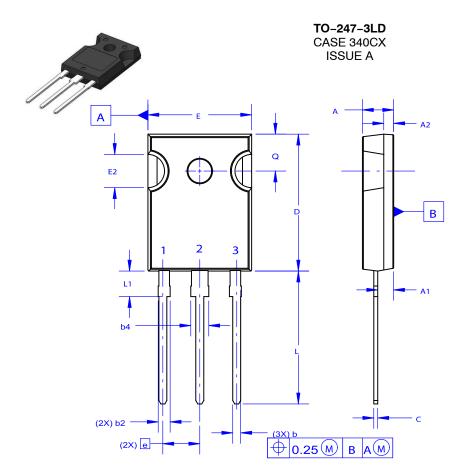
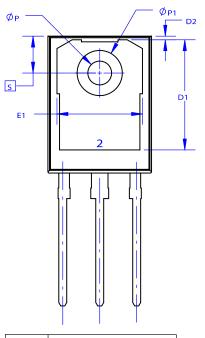


Figure 22. Transient Thermal Impedance of Diode



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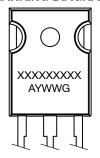


NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

 B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
D	20.32	20.57	20.82		
Е	15.37	15.62	15.87		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	19.75	20.00	20.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D1	13.08	~	?		
D2	0.51	0.93	1.35		
E1	12.81	~	1		
ØP1	6.60	6.80	7.00		

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